**TOSHIBA** SSM3K02F

TOSHIBA FIELD EFFECT TRANSISTOR SILICON N CHANNEL MOS TYPE

# **SSM3K02F**

HIGH SPEED SWITCHING APPLICATIONS

Small Package

:  $R_{on} = 200 \,\mathrm{m}\Omega \,(\mathrm{Max}) \,(\mathrm{V}_{GS} = 4 \,\mathrm{V})$ Low on Resistance

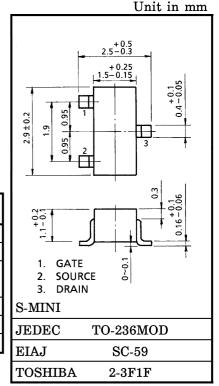
:  $R_{on} = 250 \, m\Omega \, (Max) \, (V_{GS} = 2.5 \, V)$ 

Low Gate Threshold Voltage :  $V_{th} = 0.6 \sim 1.1 \, V$ 

 $(V_{DS} = 3 V, I_{D} = 0.1 mA)$ 

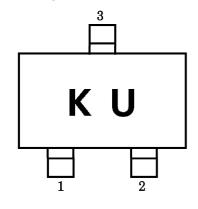
# MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC		SYMBOL	RATING	UNIT
Drain-Source Voltage		$V_{DS}$	30	V
Gate-Source Voltage		$v_{GSS}$	±10	V
Drain Current	DC	$I_{\mathbf{D}}$	1.0	_
	Pulse	$I_{\mathrm{DP}}$	2.0	A
Drain Power Dissipation		$P_{\mathbf{D}}$	200	mW
Channel Temperature		$\mathrm{T_{ch}}$	150	$^{\circ}\mathrm{C}$
Storage Temperature Range		$T_{ m stg}$	-55~150	°C

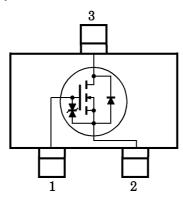


Weight: 0.012 g

## **MARKING**



#### **EQUIVALENT CIRCUIT**



## HANDLING PRECAUTION

When handling individual devices (which are not yet mounted on a circuit board), be sure that the environment is protected against electrostatic electricity. Operators should wear anti-static clothing, and containers and other objects that come into direct contact with devices should be made of anti-static materials.

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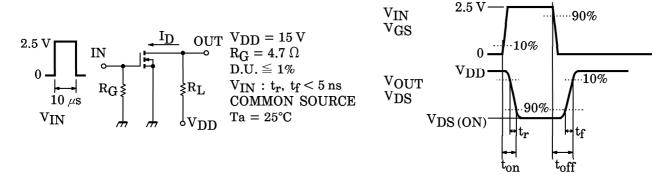
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<b>ELECTRICAL CHARACTERISTICS (Ta</b>	=	25°C)
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CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Gate Leakage Current	$I_{GSS}$	$V_{GS} = \pm 10  V,  V_{DS} = 0$	_	l —	±5	$\mu$ A
Drain-Source Breakdown Voltage	V (BR) DSS	$I_D = 1 \text{ mA}, V_{GS} = 0$	30	_	_	V
Drain Cut-off Current	$I_{ m DSS}$	$V_{DS} = 30 \text{ V}, V_{GS} = 0$	_	_	1	$\mu$ A
Gate Threshold Voltage	$ m V_{th}$	$V_{ m DS} = 3   m V,  I_{ m D} = 0.1   m mA$	0.6	_	1.1	V
Forward Transfer Admittance	Y <sub>fs</sub>	$V_{DS} = 3 \text{ V}, I_{D} = 0.5 \text{ A}$ (Note 1)	1.5	_	_	S
Drain-Source ON Resistance	R <sub>DS</sub> (ON)	$I_D = 0.5 \text{ A}, V_{GS} = 4 \text{ V}$ (Note 1) $I_D = 0.5 \text{ A}, V_{GS} = 2.5 \text{ V}$ (Note 1)	_	140 180	200 250	$\mathbf{m}\Omega$
Input Capacitance	$C_{iss}$	$V_{DS} = 10 \text{ V}, V_{GS} = 0, f = 1 \text{ MHz}$	_	115	_	pF
Reverse Transfer Capacitance	$C_{rss}$	$V_{ m DS} = 10 \  m V, \ V_{ m GS} = 0, \  m f = 1 \  m MHz$	_	24	_	pF
Output Capacitance	Coss	$V_{DS} = 10 \text{ V}, \ V_{GS} = 0, \ f = 1 \text{ MHz}$	_	60	_	pF
Switching Turn-on Time	ton	$V_{DD} = 15 \text{ V}, I_{D} = 0.5 \text{ A},$	_	52	_	n a
Time Turn-off Time	$t_{ m off}$	$V_{GS} = 0 \sim 2.5 \text{ V}, R_{G} = 4.7 \Omega$	_	80	_	ns

(Note 1): Pulse test

# SWITCHING TIME TEST CIRCUIT

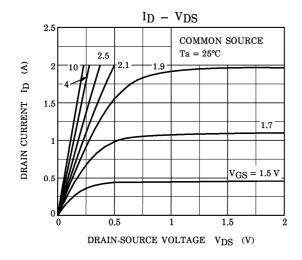


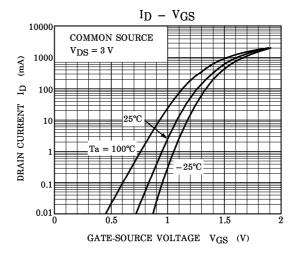
## **PRECAUTION**

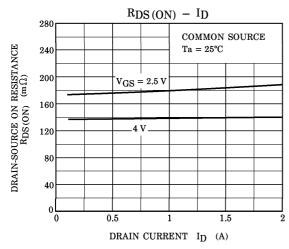
Vth can be expressed as voltage between gate and source when low operating current value is  $I_D=100~\mu A$  for this product. For normal switching operation,  $V_{GS\,(ON)}$  requires higher voltage than  $V_{th}$  and  $V_{GS\,(off)}$  requires lower voltage than  $V_{th}.$  (Relationship can be established as follows:  $V_{GS\,(off)} < V_{th} < V_{GS\,(ON))}$ 

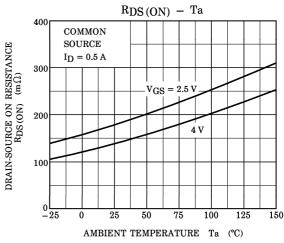
Please take this into consideration for using the device.

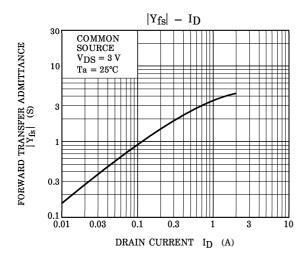
VGS recommended voltage of 2.5 V or higher to turn on this product.

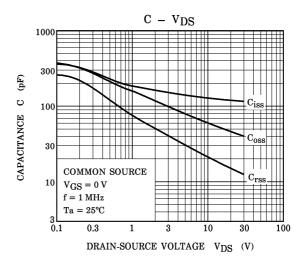




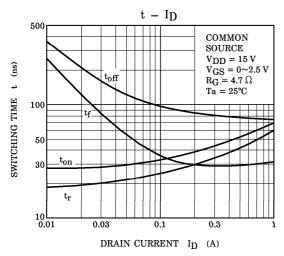


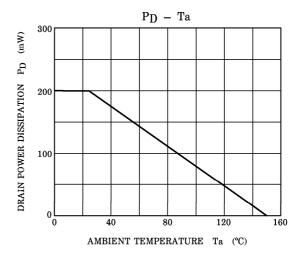


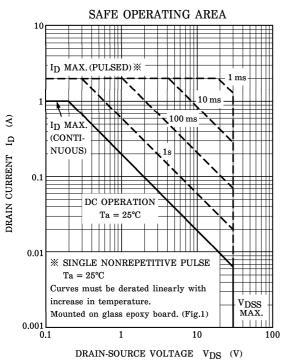




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(Fig.1) :  $25.4 \, \text{mm} \times 25.4 \, \text{mm} \times 1.6 \, t \, (a \, \text{Cu pad of } 0.8 \, \text{mm}^2 \, \text{area})$ 

